

Parameter		Symbol	Тур	Max	Units
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	31	40	C/W
Maximum Junction-to-Ambient A	Steady State	$\kappa_{\theta JA}$	59	75	C/W
Maximum Junction-to-Lead ^C	Steady State	$R_{ ext{ hetaJL}}$	16	24	°C/W

Symbol	Parameter	Parameter Conditions		Min	Тур	Max	Units
STATIC P	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0V$		40			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$				1	μA
			T _J = 55℃			5	μπ
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 20V$,			±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = 250 \mu A$		1.7	2.2	3	V
I _{D(ON)}	On state drain current	$V_{GS} = 10V, V_{DS} = 5V$		120			А
		$V_{GS} = 10V, I_{D} = 10A$			8.2	10	
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125℃		12.5	16	mΩ
		$V_{GS} = 4.5V, I_D = 8A$			10	12.5	
g fs	Forward Transconductance	$V_{DS} = 5V, I_{D} = 10A$			75		S
V _{SD}	Diode Forward Voltage	$I_{\rm S}$ = 1A, $V_{\rm GS}$ = 0V			0.72	1	V
I _S	Maximum Body-Diode Continuous Curr			2.5	А		
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, f=1MHz			1500	1950	pF
C _{oss}	Output Capacitance				215		pF
C _{rss}	Reverse Transfer Capacitance				135		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		2	3.5	5	Ω
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =20V, I _D =10A			27.2	37	nC
Q _g (4.5V)	Total Gate Charge				13.6	18	nC
Q _{gs}	Gate Source Charge				4.5		nC
Q_{gd}	Gate Drain Charge				6.4		nC
t _{D(on)}	Turn-On DelayTime				6.4		ns
t _r	Turn-On Rise Time	V _{GS} =10V, V _{DS} =20V, F	$R_L = 2\Omega$,		17.2		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$			29.6		ns
t _f	Turn-Off Fall Time]			16.8		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =10A, dl/dt=100A/μs			30	40	ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =10A, dI/dt=100A/µ	S		19		nC

Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R_{eJA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm 6JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 6JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using t \leqslant 300 μs pulses, duty cycle 0.5% max.

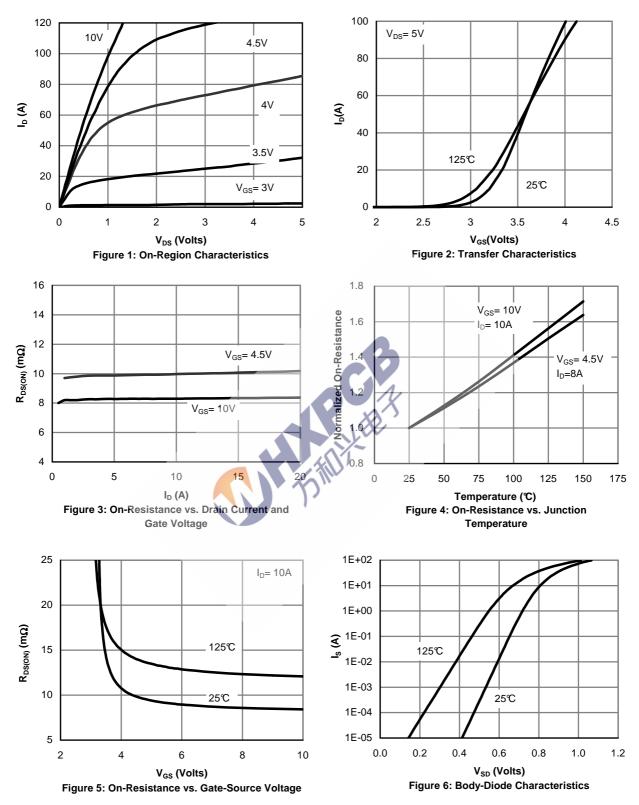
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leqslant 10s thermal resistance rating.

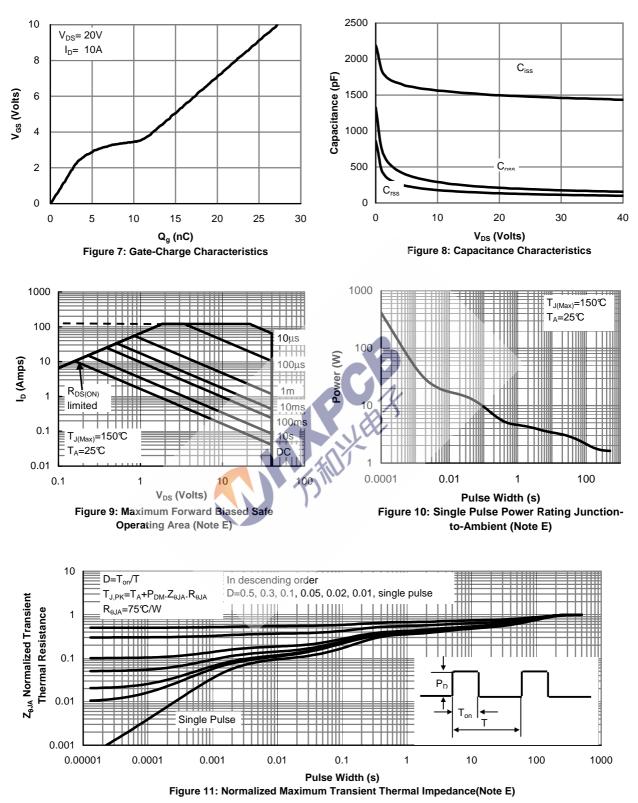
G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j=25C.

Rev1: Nov. 2010

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

I(